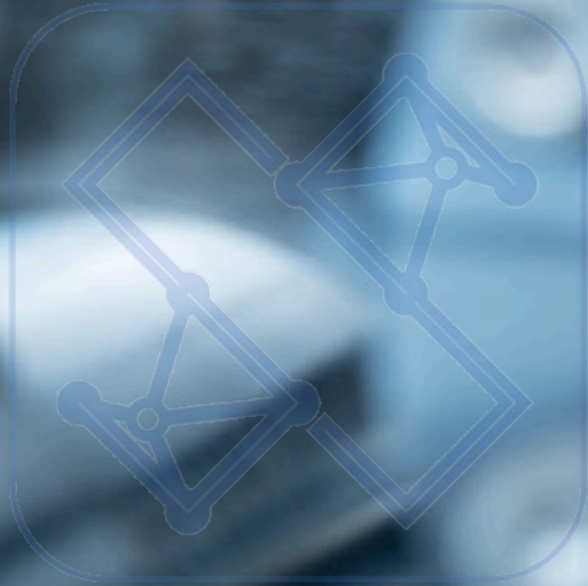


Lecture 7:

Space Charge Layers

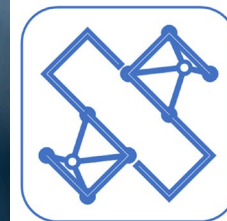


SSI Lab
WESTLAKE UNIVERSITY

Prof. Qiyang Lu

Solid State Ionics (SSI) Laboratory

School of Engineering, Westlake University



MIECs should be charge neutral except at interfaces

Poisson's equation: connecting (net) charge with potential

$$\frac{\partial^2 \phi}{\partial x^2} = -\frac{\rho}{\epsilon_0 \epsilon_r}$$

$$E = -\frac{\partial \phi}{\partial x} \rightarrow \text{Electrostatic potential}$$

↓
Electric field

Let's say if an MIEC contains 0.1 mol/L of net charge, then:

$$\frac{\Delta E}{\Delta x} = -\frac{\rho}{\epsilon_0 \epsilon_r} = -\frac{Fc}{\epsilon_0 \epsilon_r} = -\frac{\frac{96500C}{mol} \times \frac{0.1mol}{L}}{8.8 \times \frac{10^{-12}F}{m} \times 10} = 0.1 \times 10^{18} V/m^2$$

$$\Delta E = \frac{\Delta V}{\Delta x} = 1 \times 10^{18} V/m^2 \Delta x$$

For a sample with area of 1 cm²

Δx	ΔV	U_E
1 nm	1 V	$\sim 10^{-6}$ J
1 μ m	10^6 V	$\sim 10^3$ J
1 mm	10^{12} V	$\sim 10^{12}$ J

1 TNT equivalent:
 4.184×10^9 J



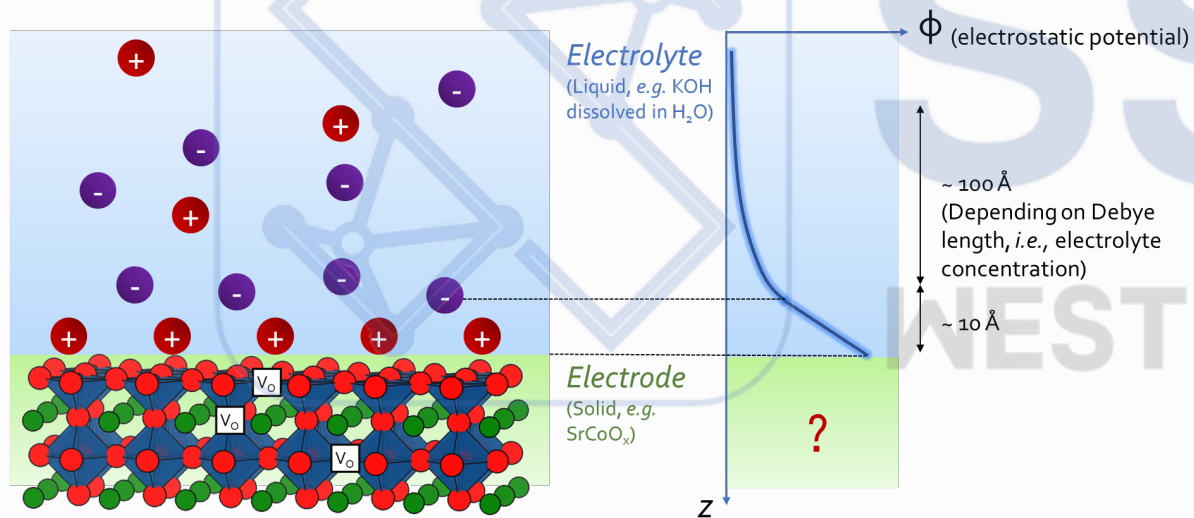
($c = 1 \text{ mol/L}$ or $c = 6.02 \times 10^{19} \text{ cm}^{-3}$)

Electric potential energy
 $U_E = \rho \Delta V$

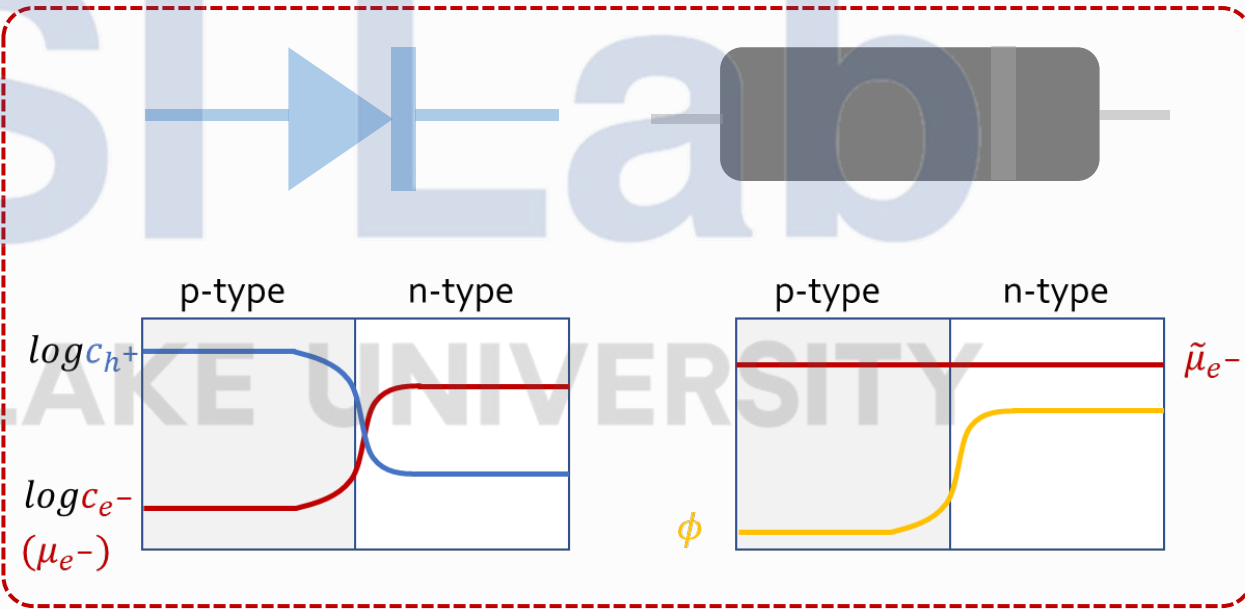
What will you learn in this course on Solid State Ionics?

Goal:

By the end of the semester, you will have a clear physical picture on the **diffusion & reactions** related with **ions in solid state** and have the tools to analyze the *fundamental physical chemistry process*.



Electric double layers (EDLs)



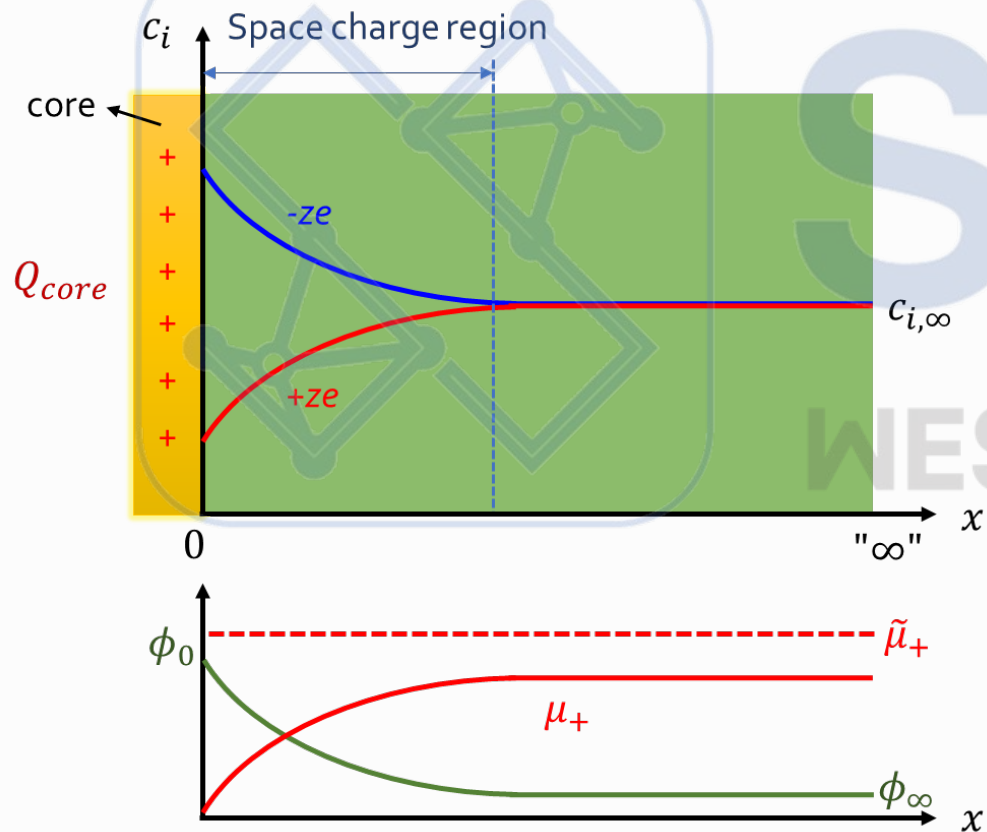
p-n junctions (diodes)

Is there any similarities between EDLs and p-n junctions?

Space charge layers

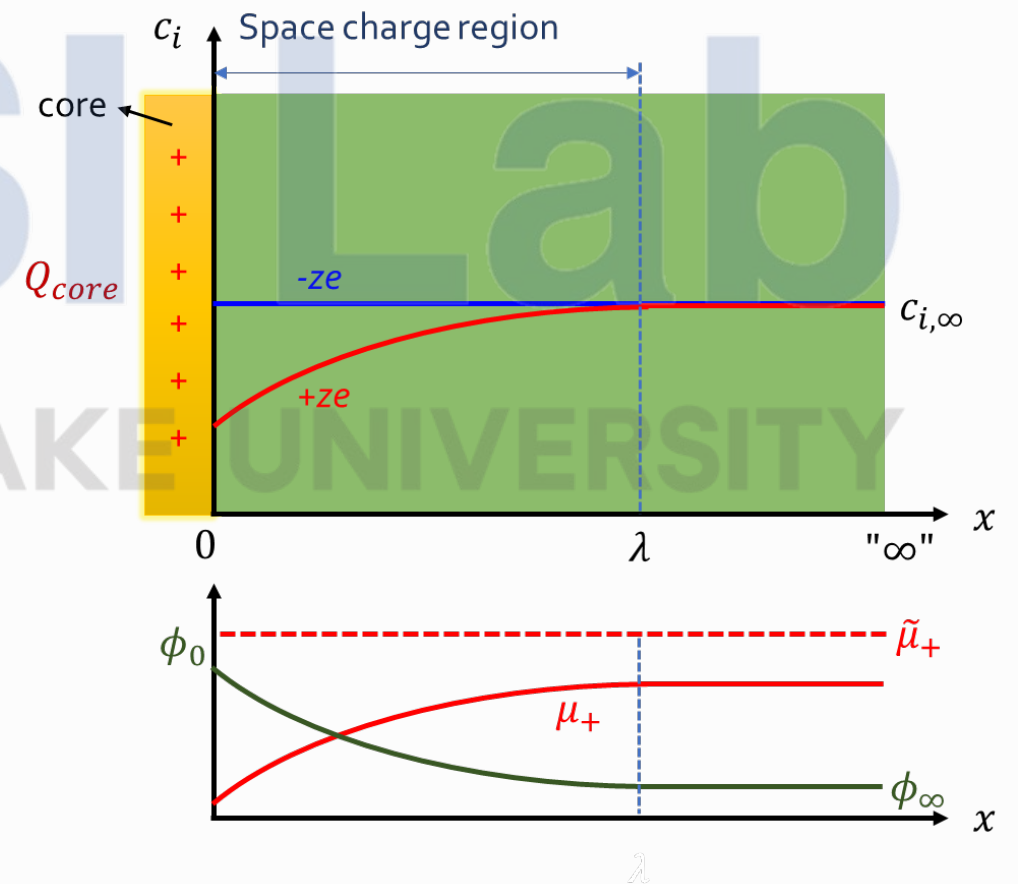
Electric double layers (EDLs)

Gouy-Chapman case



p - n junctions (diodes)

Mott-Schottky case

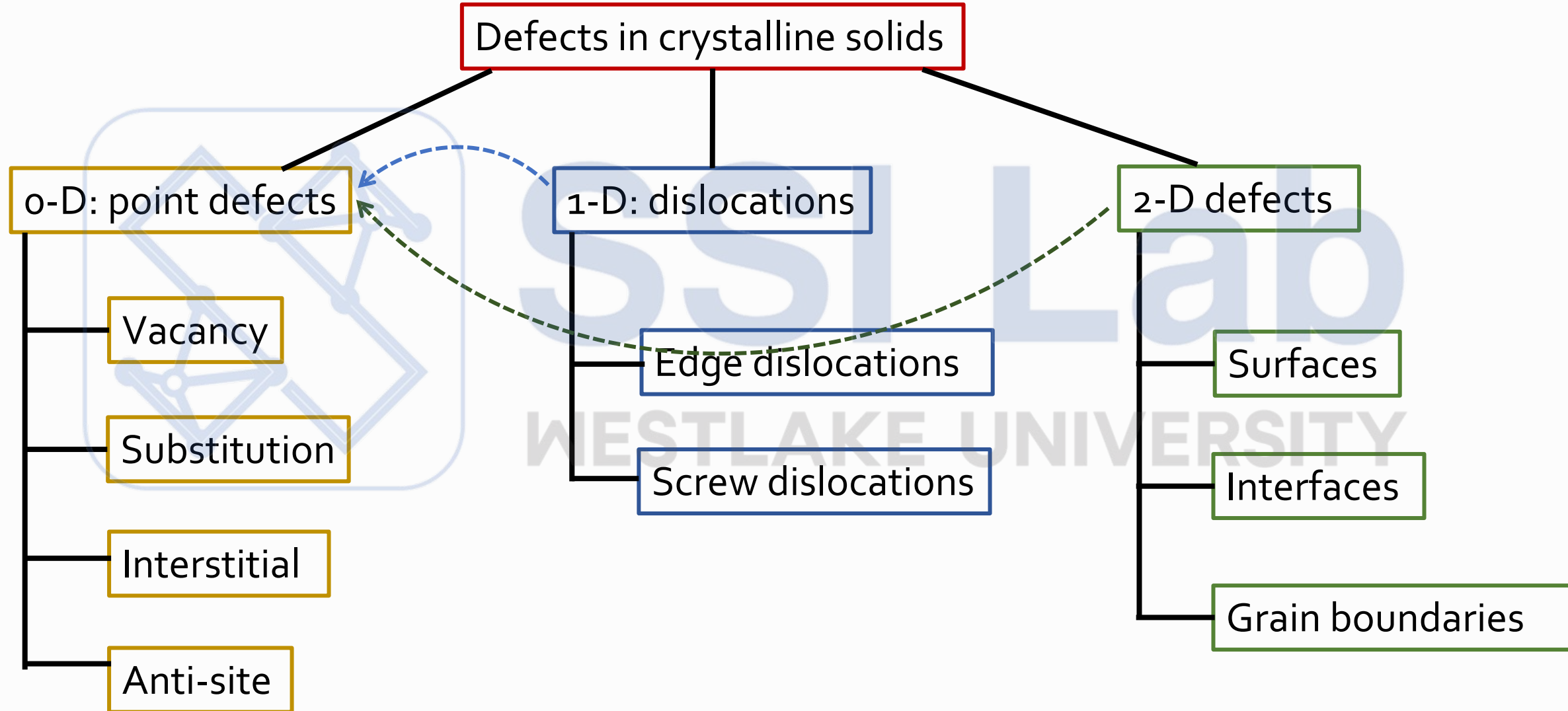


Space charge layers:

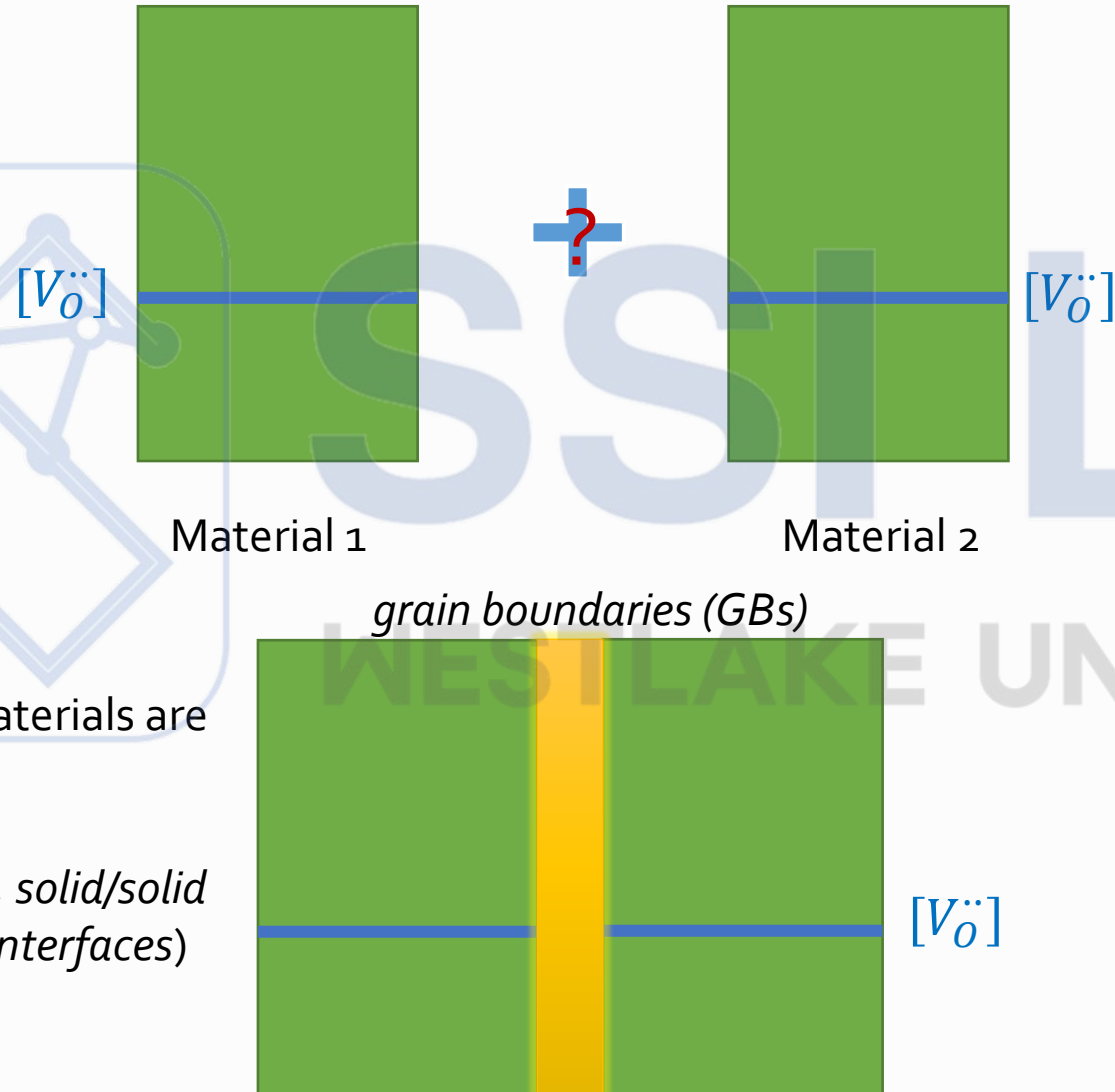
- What is the physical picture and assumptions of the space charge layer theory?
- How to model the distribution of ionic/electronic defects in the space charge layers?
- What are the difference between the Gouy-Chapman and Mott-Schottky cases?
- How to model the distribution of ionic/electronic defects in the space charge layers?
- What are the effects of space charge layers on the conductivity of bulk (poly-crystalline) materials?

Goal of this lecture: you should be able to answer the questions above by the end of this lecture :)

Categories of defects with different dimensions

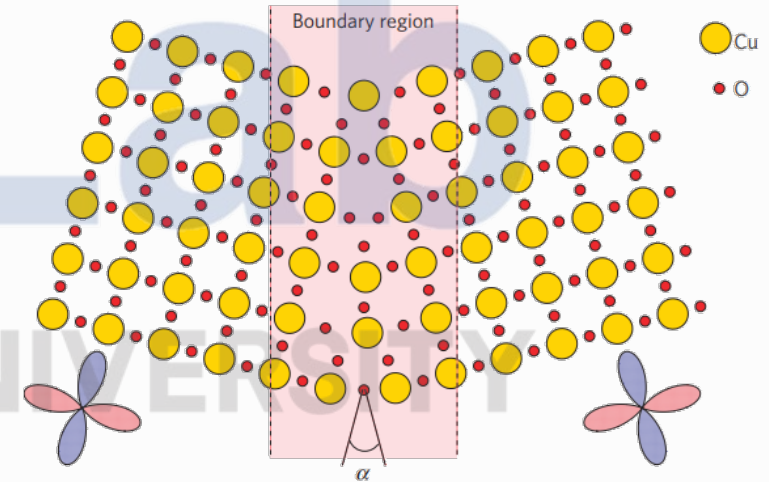


What happens when two materials are put together?



What happens when two materials are put together?

(e.g., grain boundaries (GBs), solid/solid heterostructure, solid/liquid interfaces)



Graser et al., *Nat. Phys.*, 2010

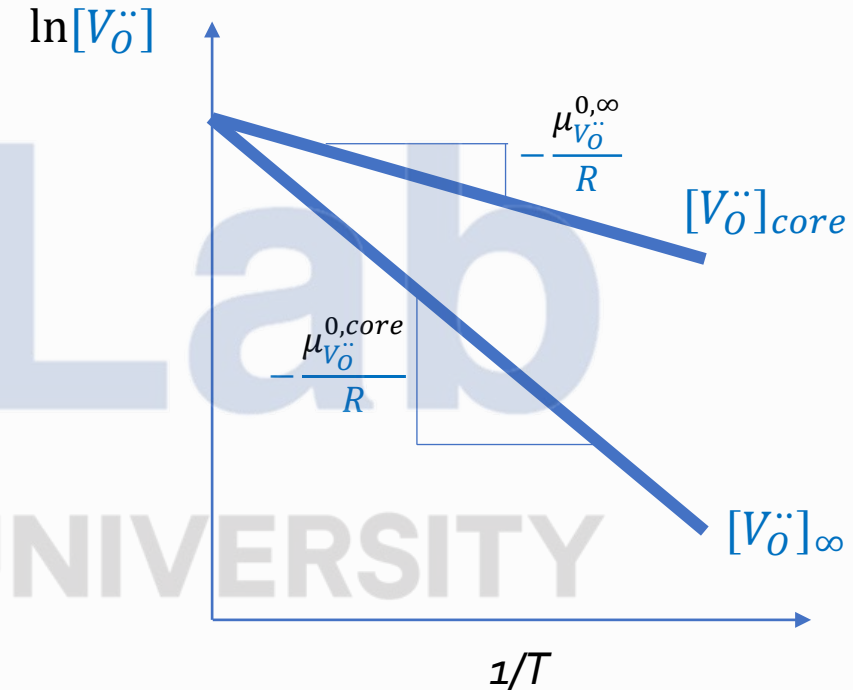
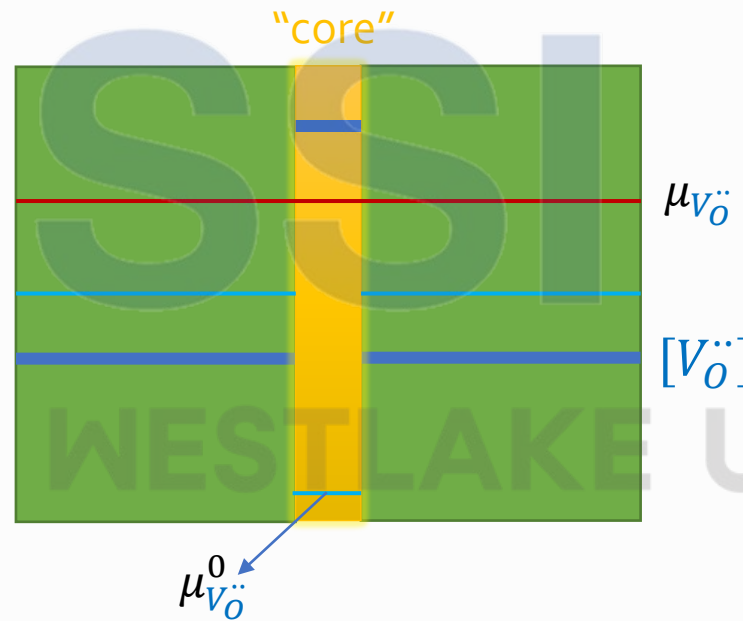
What happens when two materials are put together?

Normally defect formation energy is lower at GBs due to more open space.

$$\mu_{V\ddot{O}} = \mu_{V\ddot{O}}^0 + RT \ln[V\ddot{O}]$$

$$\frac{[V\ddot{O}]_{core}}{[V\ddot{O}]_{\infty}} = \exp\left(-\frac{\mu_{V\ddot{O}}^{0,core} - \mu_{V\ddot{O}}^{0,\infty}}{RT}\right)$$

core = grain boundary
 ∞ = bulk



1. At equilibrium, the chemical potential of defects must be the same inside the core and in the bulk (here we ignore the charge for the moment)
2. A lower standard chemical potential ($\mu_{V\ddot{O}}^0$) means higher $[V\ddot{O}]$.

Now we also need to consider the extra charge

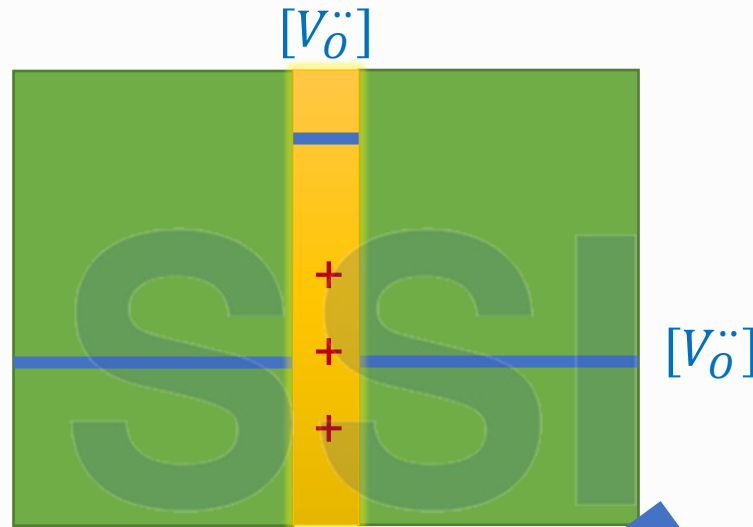
The treatment in the last slide ignored the fact that oxygen vacancies are positively charged.

Instead, we should use **electro**chemical potential rather than chemical potential

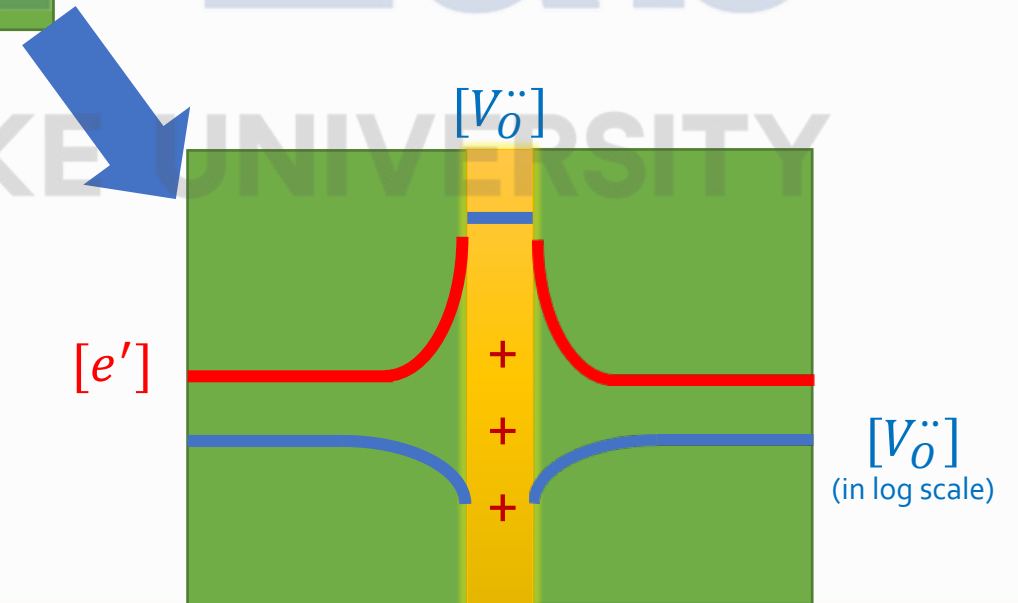
Electrochemical potential

$$\tilde{\mu}_{V\ddot{O}} = \mu_{V\ddot{O}} + 2F\phi$$

The existence of extra charge will change the distribution of all **charged** point defects, including ionic defects and electronic defects (electrons/holes).



Question: How to give a quantitative description on the change of defect concentrations?



How to solve for concentration profile in the space charge region

At equilibrium, the **electro**chemical potential is flat everywhere

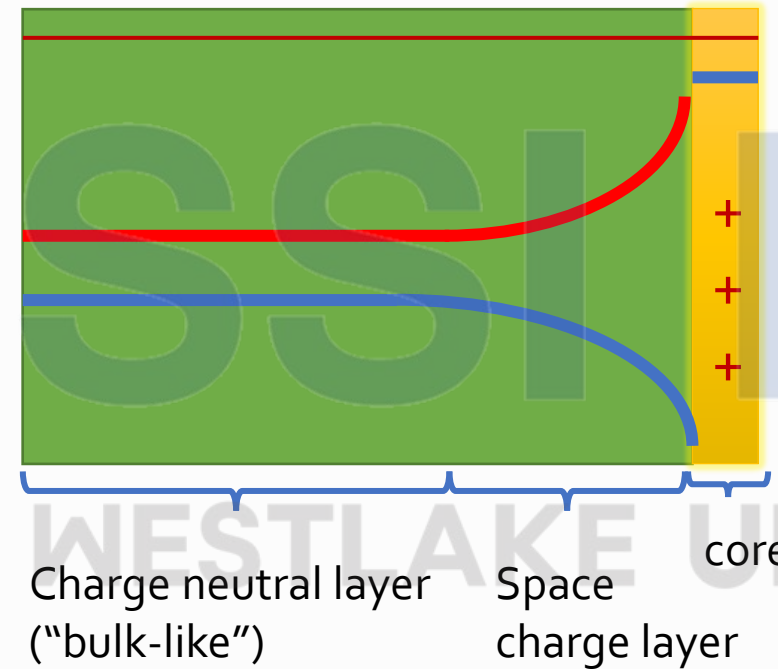
$$\tilde{\mu}_{V\ddot{O}} = \mu_{V\ddot{O}}^0 + RT \ln[V\ddot{O}] + 2F\phi \quad \begin{matrix} \tilde{\mu}_{V\ddot{O}} \\ [e'] \\ [V\ddot{O}] \end{matrix}$$

i.e., $\frac{\partial \tilde{\mu}_{V\ddot{O}}}{\partial x} = 0$

$$\frac{\partial (\mu_{V\ddot{O}}^0 + RT \ln[V\ddot{O}] + 2F\phi)}{\partial x} = 0$$

$$RT \frac{\partial \ln[V\ddot{O}]}{\partial x} = -2F \frac{\partial \phi}{\partial x}$$

Therefore, we have:

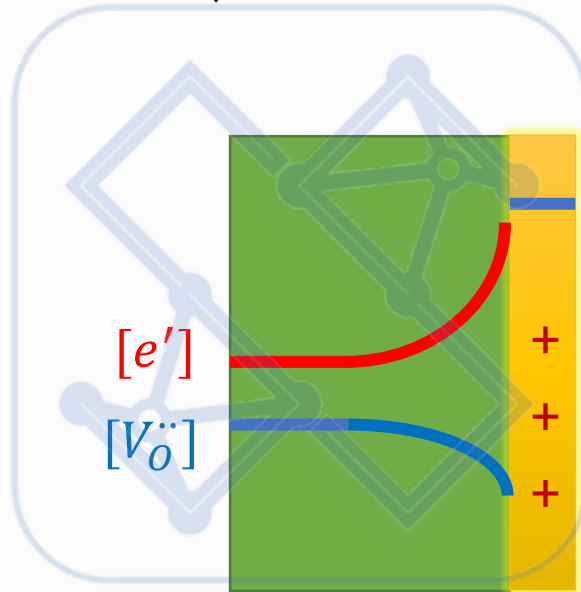


Defect concentration inside the space charge layer goes back to bulk value *exponentially*.

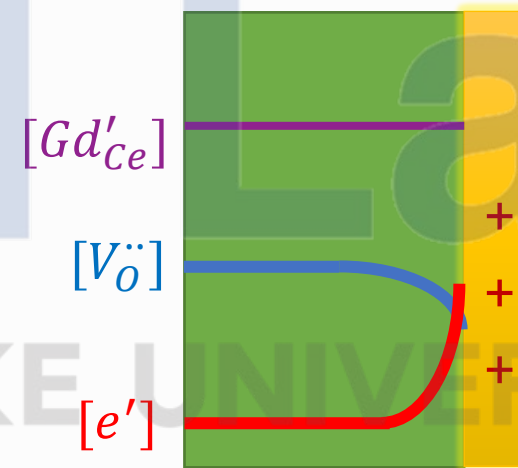
$$[V\ddot{O}] = [V\ddot{O}]_{\infty} \exp\left(-\frac{2F(\phi - \phi_{\infty})}{RT}\right)$$

The complication introduced by immobile dopants

Gouy-Chapman case
(All defects are mobile)

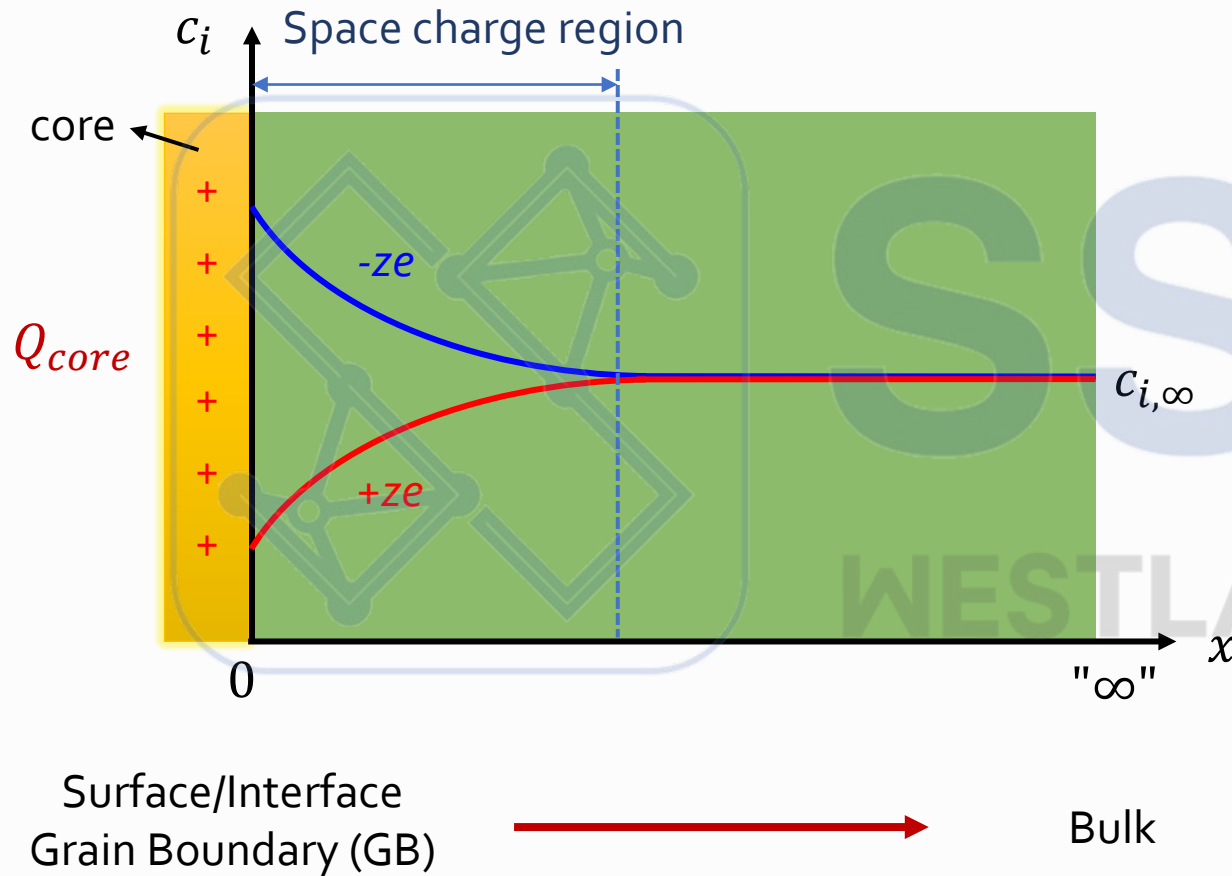


Mott-Schottky case
(Majority dopants are frozen (*immobile*))



Note: We are going to solve for the concentration/potential profiles in both cases in the next lecture.

Gouy-Chapman case: how to set up the problem?



Gouy-Chapman case \rightarrow all defects are mobile

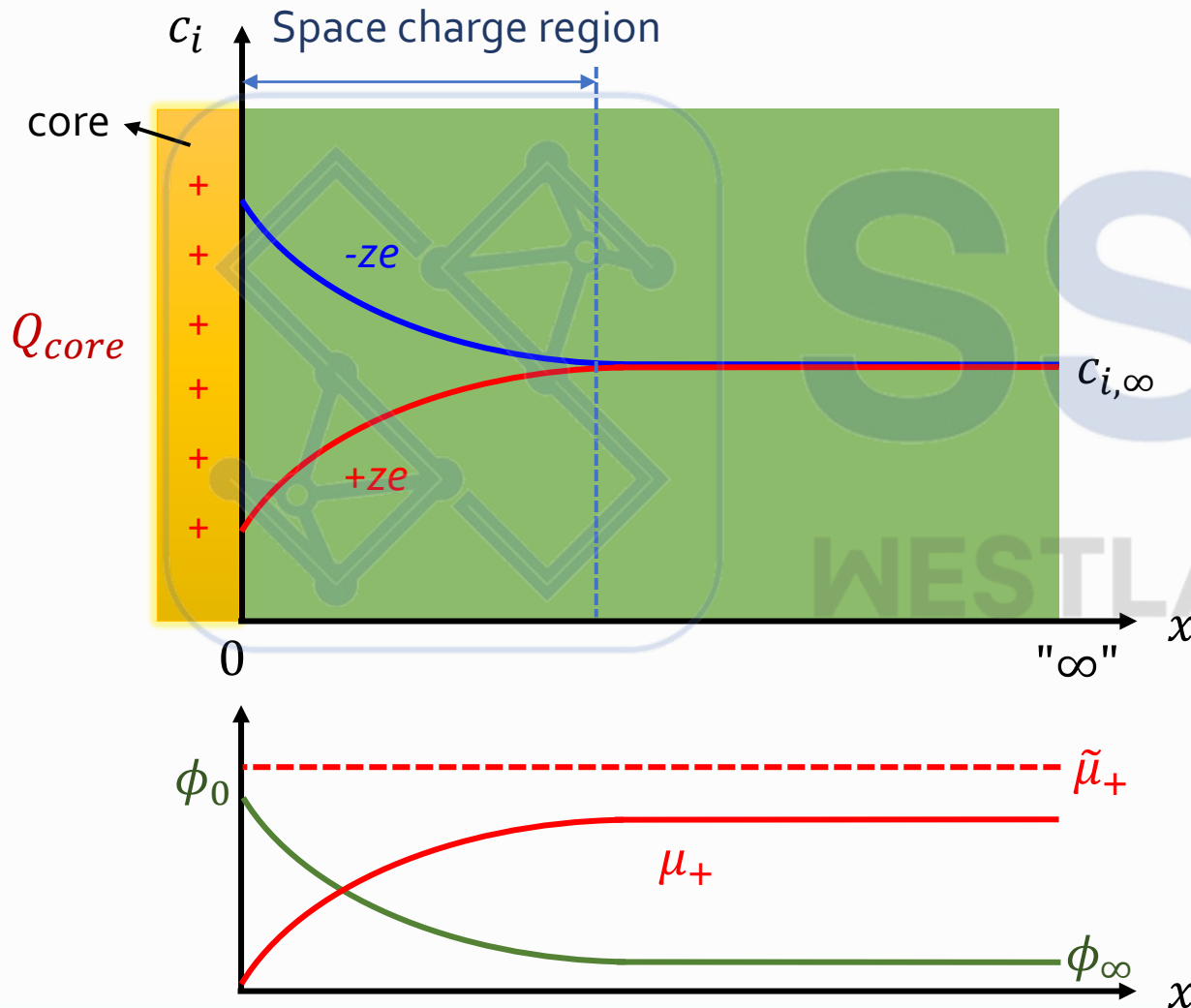
We assume a positively charged core with $+Q_{core}$ charge.
(ignore the details of the space charge core)

Assume that there are only two types of mobile defects, with positive and negative charge of $+ze/-ze$

In the bulk (" ∞ ") of the solid, *electro-neutrality* applies, we have:

$$c_{-}(\infty) = c_{+}(\infty) = c_{i,\infty}$$

Gouy-Chapman case: concentration/potential profile



In the space charge region, the **electrochemical potential** of each defects determines the equilibrium:

$$\tilde{\mu}_+(x) = \mu_+(x) + ze\phi(x)$$

$$\tilde{\mu}_-(x) = \mu_-(x) - ze\phi(x)$$

$$\mu_+(x) = \mu_+^0 + k_B T \ln c_+(x)$$

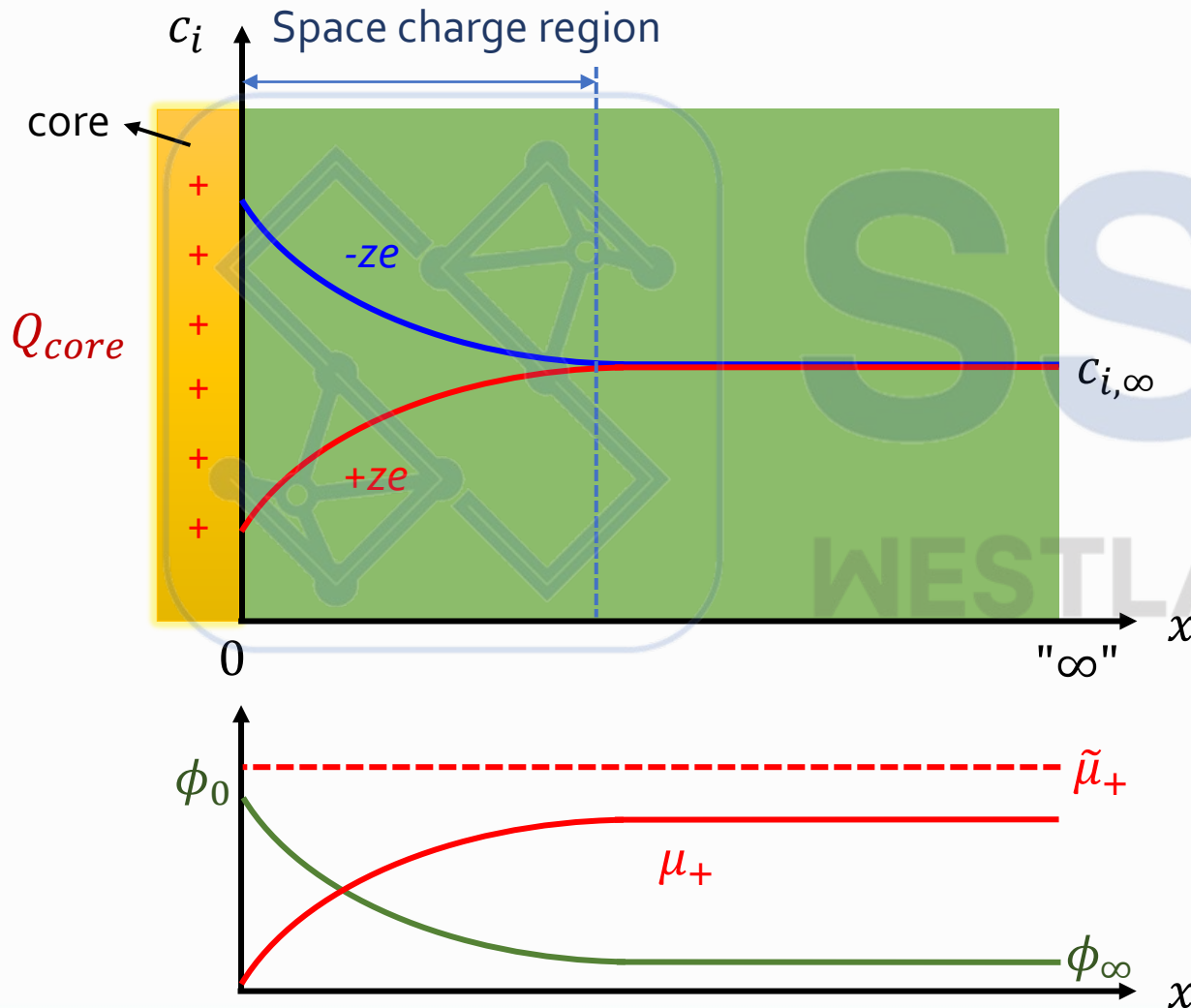


$$c_+(0) = c_+(\infty) \exp\left(-\frac{ze(\phi_0 - \phi_\infty)}{k_B T}\right)$$

We can set $\phi_\infty = 0$ (reference point), then

$$\frac{c_+(x)}{c_{i,\infty}} = \exp\left(-\frac{ze\phi(x)}{k_B T}\right)$$

Gouy-Chapman case: concentration/potential profile



$$c_+(x) = c_{i,\infty} \exp\left(-\frac{ze\phi(x)}{k_B T}\right)$$

$$c_-(x) = c_{i,\infty} \exp\left(+\frac{ze\phi(x)}{k_B T}\right)$$

At $x = 0$:

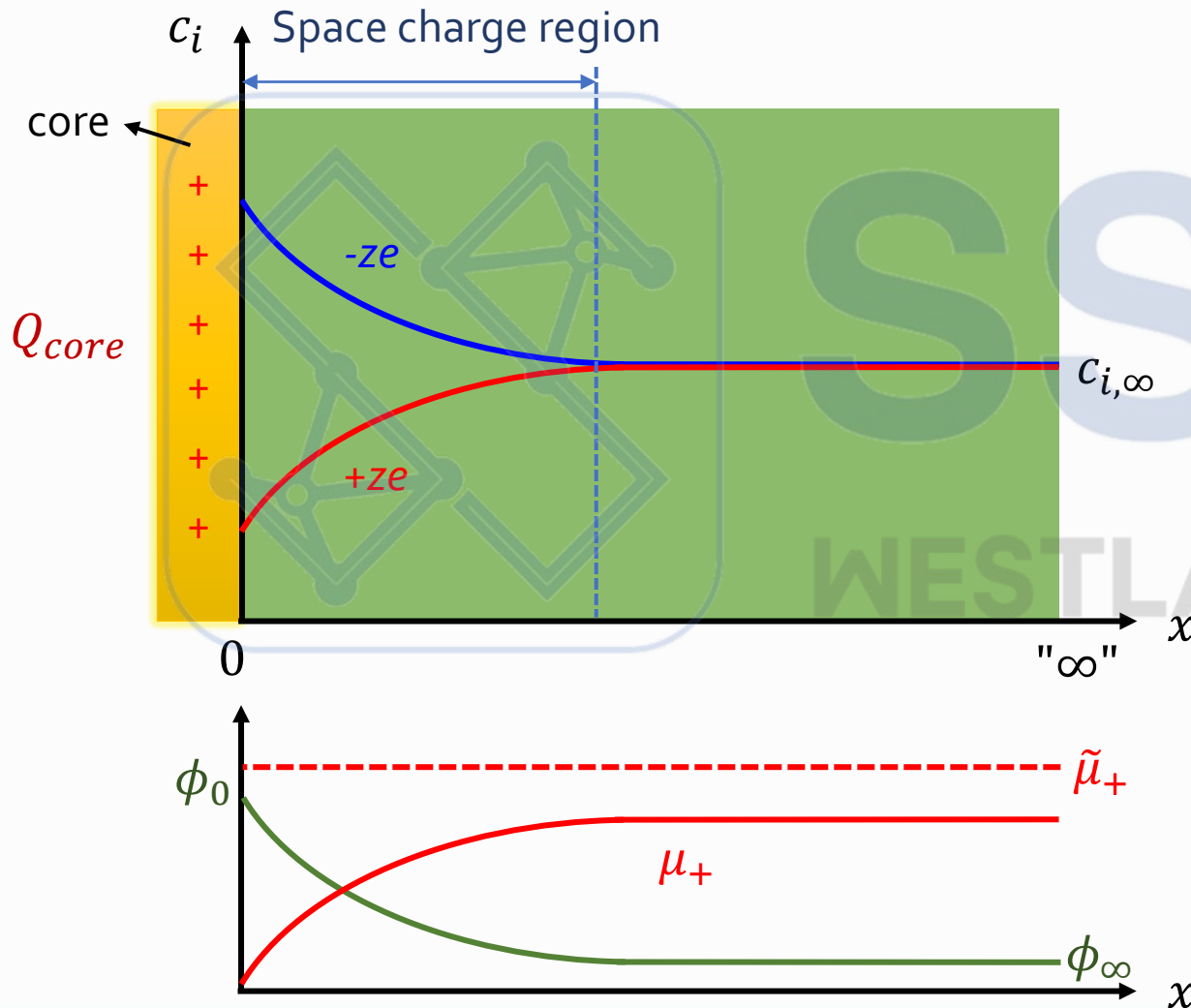
$$\rho(0) = ze c_+(0) - ze c_-(0) = 2ze c_{i,\infty} \sinh\left(-\frac{ze\phi_0}{k_B T}\right)$$

If $ze\phi_0 \ll k_B T$, we can linearize the equation:

$$\rho(0) = -2ze c_{i,\infty} \frac{ze\phi_0}{k_B T}$$

$$\rho(x) = -2ze c_{i,\infty} \frac{ze\phi(x)}{k_B T}$$

Gouy-Chapman case: concentration/potential profile



$$\rho(x) = -2ze c_{i,\infty} \frac{ze\phi(x)}{k_B T}$$

Apply Poisson's equation:

$$\frac{d^2\phi}{dx^2} = -\frac{\rho(x)}{\epsilon_0 \epsilon_r} = \frac{2z^2 e^2 c_{i,\infty}}{\epsilon_0 \epsilon_r k_B T} \phi(x)$$

We define **Debye length** λ_D as:

$$\lambda_D = \sqrt{\frac{\epsilon_0 \epsilon_r k_B T}{2z_i^2 c_{i,\infty} e^2}}$$

Then we have:

$$\frac{d^2\phi}{dx^2} = \frac{\phi(x)}{\lambda_D^2}$$

$$\phi(x) = \phi_0 \exp(-x/\lambda_D)$$

(We set $\phi_\infty = 0$)

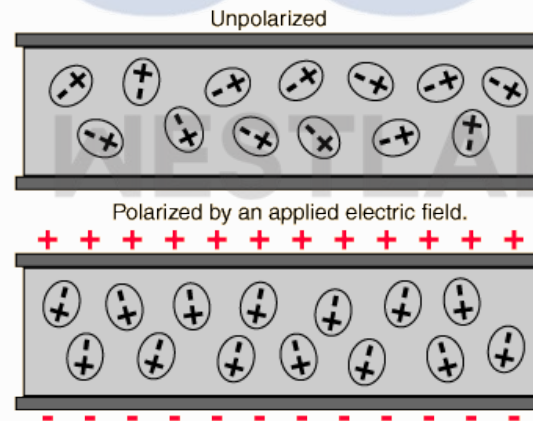
Debye length: how wide is the space charge region?

In Gouy-Chapman case, **Debye length** λ_D is defined as:

$$\lambda_D = \sqrt{\frac{\epsilon_0 \epsilon_r k_B T}{2 z_i^2 c_{i,\infty} e^2}}$$

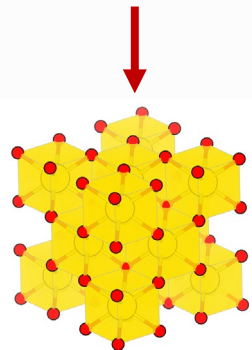
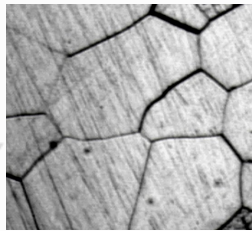
Note: 1. $\epsilon_0 \epsilon_r$: dielectric constant (permittivity) strongly affects space charge width

2. $c_{i,\infty}$: charge carrier concentration in the bulk. A higher charge carrier concentration will **screen** the core charges more effectively.



For $z_i^2 = 1$, $\epsilon_r = 10$, $T = 300$ K:

$c_{i,\infty}$	λ_D
10^{18} cm^{-3} (~1 mM)	~100 nm
10^{20} cm^{-3} (~0.1 mol/L)	~10 nm
10^{22} cm^{-3} (~10 mol/L)	~1 nm



<http://hyperphysics.phy-astr.gsu.edu/hbase/electric/dielec.html#c1>

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Cite this: *Phys. Chem. Chem. Phys.*,
2022, 24, 11945

Discrete modeling of ionic space charge zones in solids†

Chuanlian Xiao, Chia-Chin Chen and Joachim Maier*

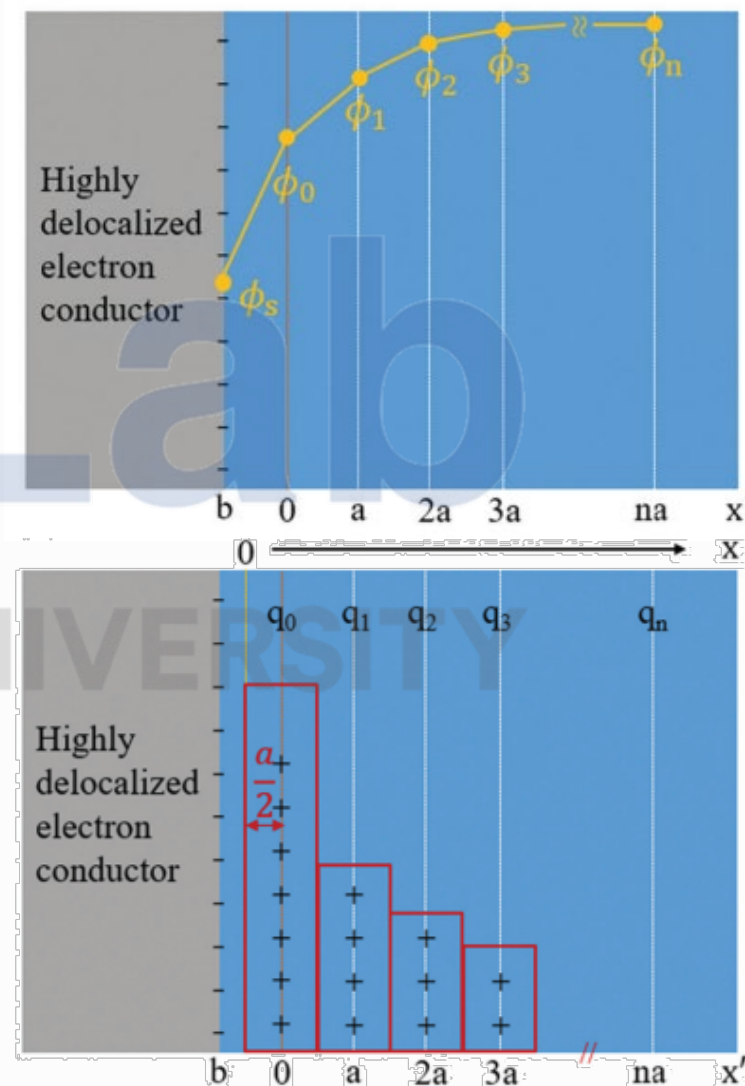
The discrete model of space charge zones in solids reveals and remedies a variety of problems with the classic continuous Gouy–Chapman solution that occur for pronounced space charge potentials. Besides inherent problems of internal consistency, it is essentially the extremely steep profile close to the interface which makes this continuum approach questionable. Not only is quasi-1D discrete modeling a sensible approach for large space charge effects, it can also favorably be combined with the continuum description. A particularly useful application is the explicit implementation of crystallographic details and non-idealities close to the interface. This enables us to consider elastic, structural or saturation effects as well as permittivity variations in a simple but realistic way. We address details of the charge carrier profiles, but also overall properties such as space charge capacitance and space charge resistance. In the latter case the difference in the total charge (at identical concentration) is of importance, in the first case it is the inherent difference in the centroid of charge (at identical total charge) that is remarkable. The model is equally applicable for ionic charge carriers and small polarons.

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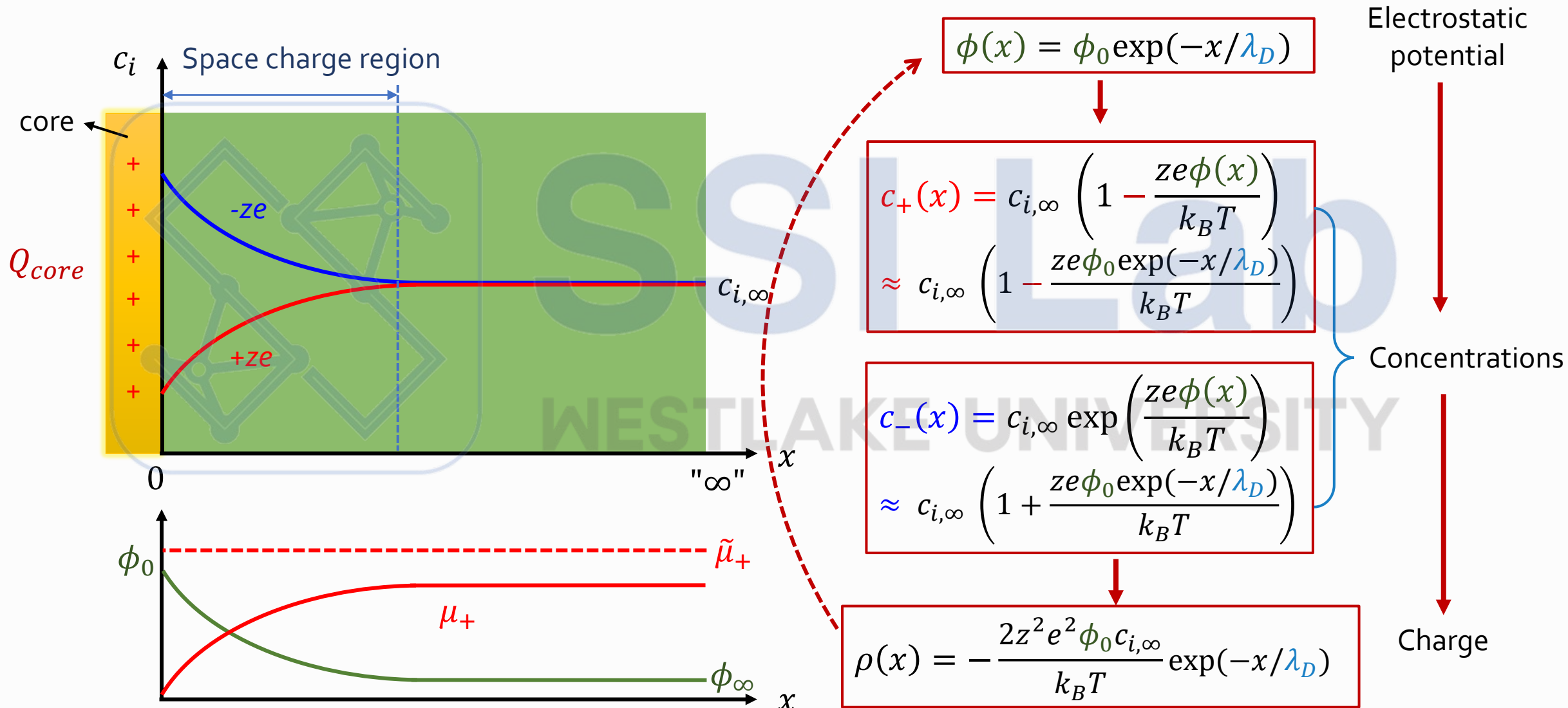
DOI: 10.1039/d1cp05293d

rsc.li/pccp

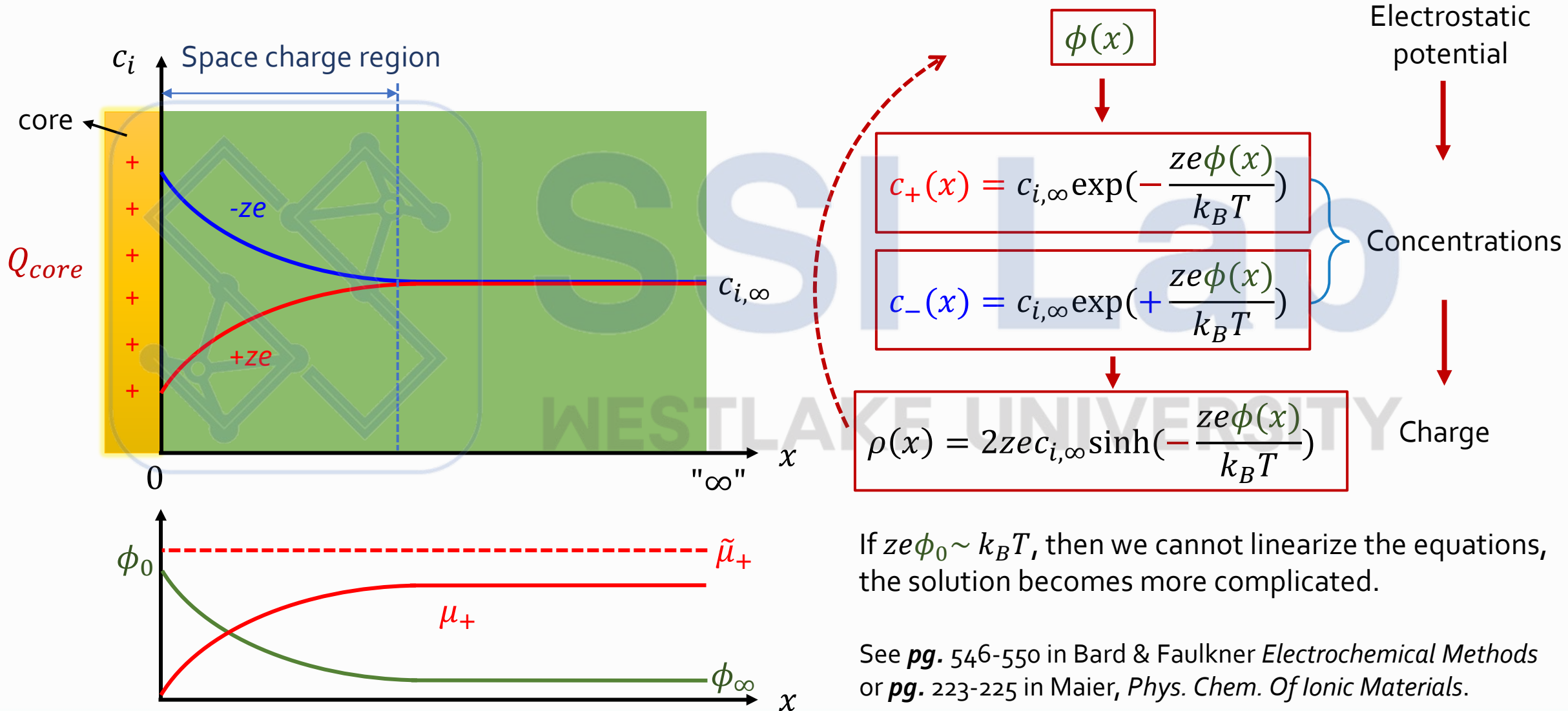
Continuous → Discrete as the λ_D shrinks



Gouy-Chapman case: concentration/potential profile

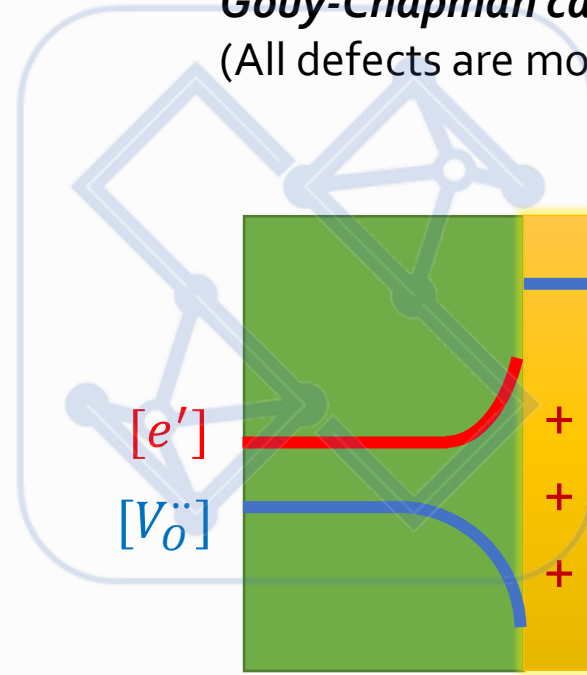


Gouy-Chapman case: concentration/potential profile

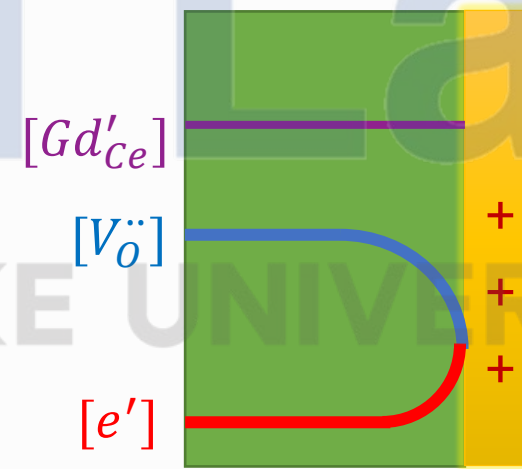


The complication introduced by immobile dopants

Gouy-Chapman case
 (All defects are mobile)

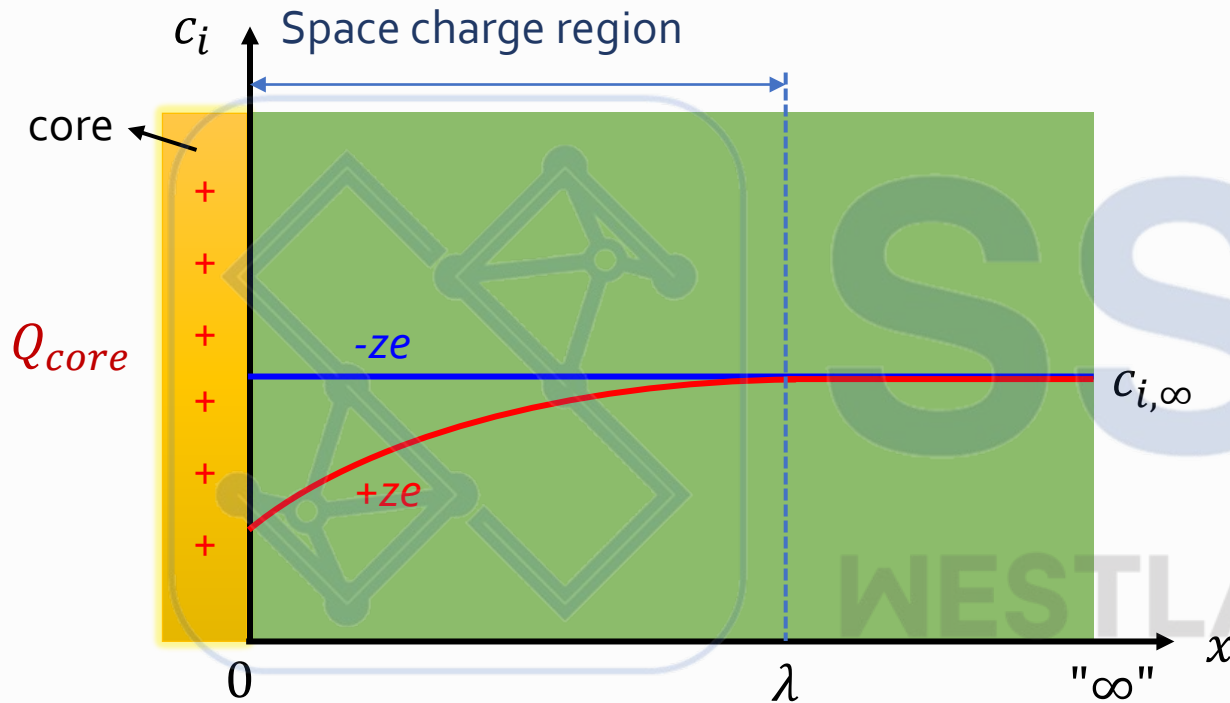


Mott-Schottky case
 (Majority dopants are frozen (*immobile*))



Note: We are going to discuss how to solve for the concentration and potential profiles of these two cases in this lecture.

Mott-Schottky case: how to set up the problem?



Surface/Interface
Grain Boundary (GB)

Bulk

Mott-Schottky case \rightarrow one of the majority charge carrier defects (usually dopants) are immobile (frozen)

Assume the negatively charged ($-ze$) defects are immobile, while the positively charged defects are mobile ($+ze$)

Ex. 1 in p-n junctions, the dopants at "depletion layer" are frozen, while electrons/holes are mobile.

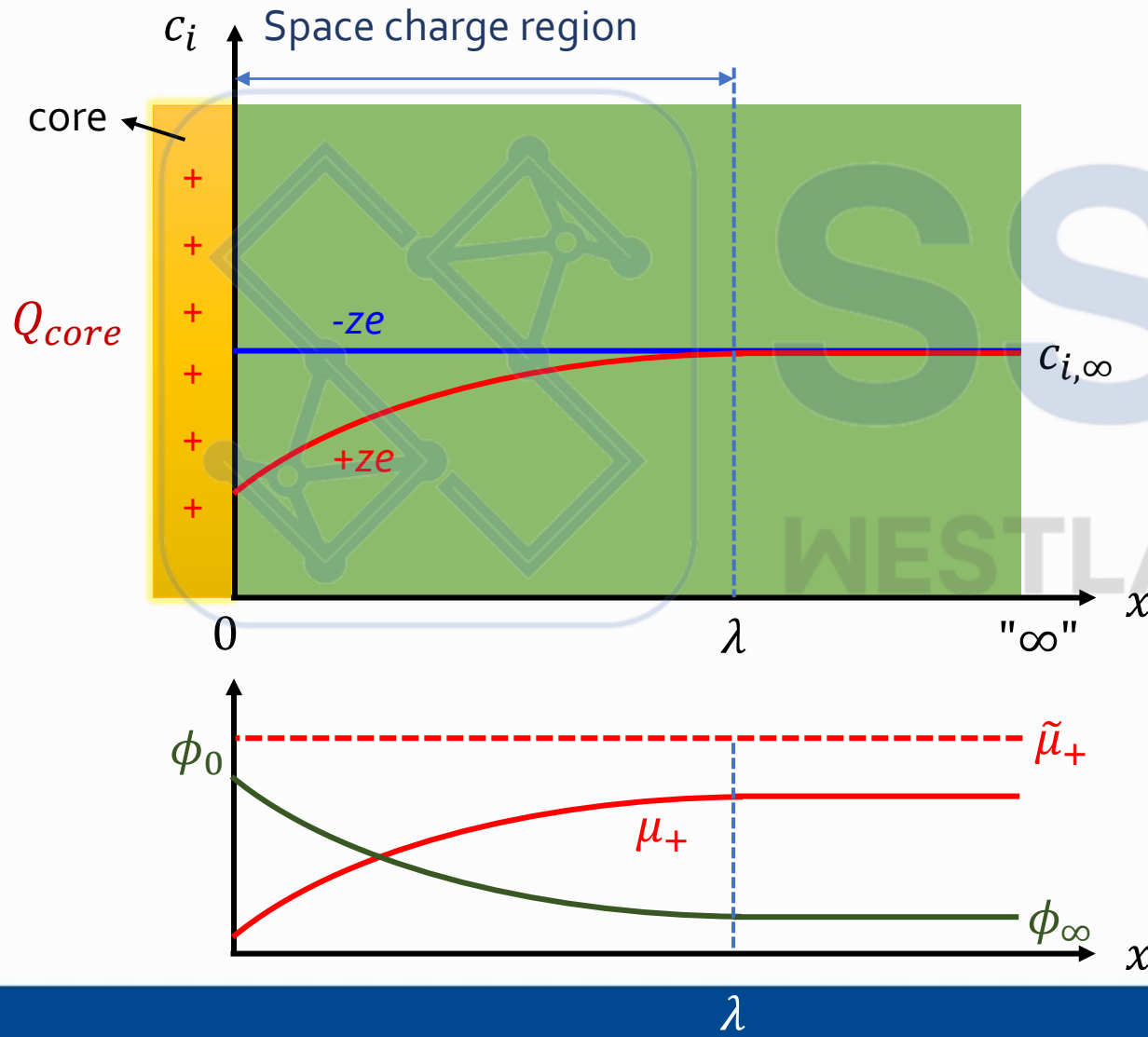
Ex. 2 in $(\text{Sm}, \text{Ce})\text{O}_{2-\delta}$ Sm'_{Ce} are immobile while V_O are mobile at intermediate temperature.

In the bulk ("infinity") of the solid, *electro-neutrality still* applies, we have:

Intuitively, the space charge region becomes **thicker** in Mott-Schottky case due to **insufficient screening**

$$c_- (\infty) = c_+ (\infty) = c_{i,\infty}$$

Mott-Schottky case: concentration/potential profile



Since $-ze$ defects are immobile:

$$c_-(x) = c_{i,\infty} \quad (const.)$$

In the space charge region, the screening (negative) charge is mainly provided by the $-ze$ defects, therefore:

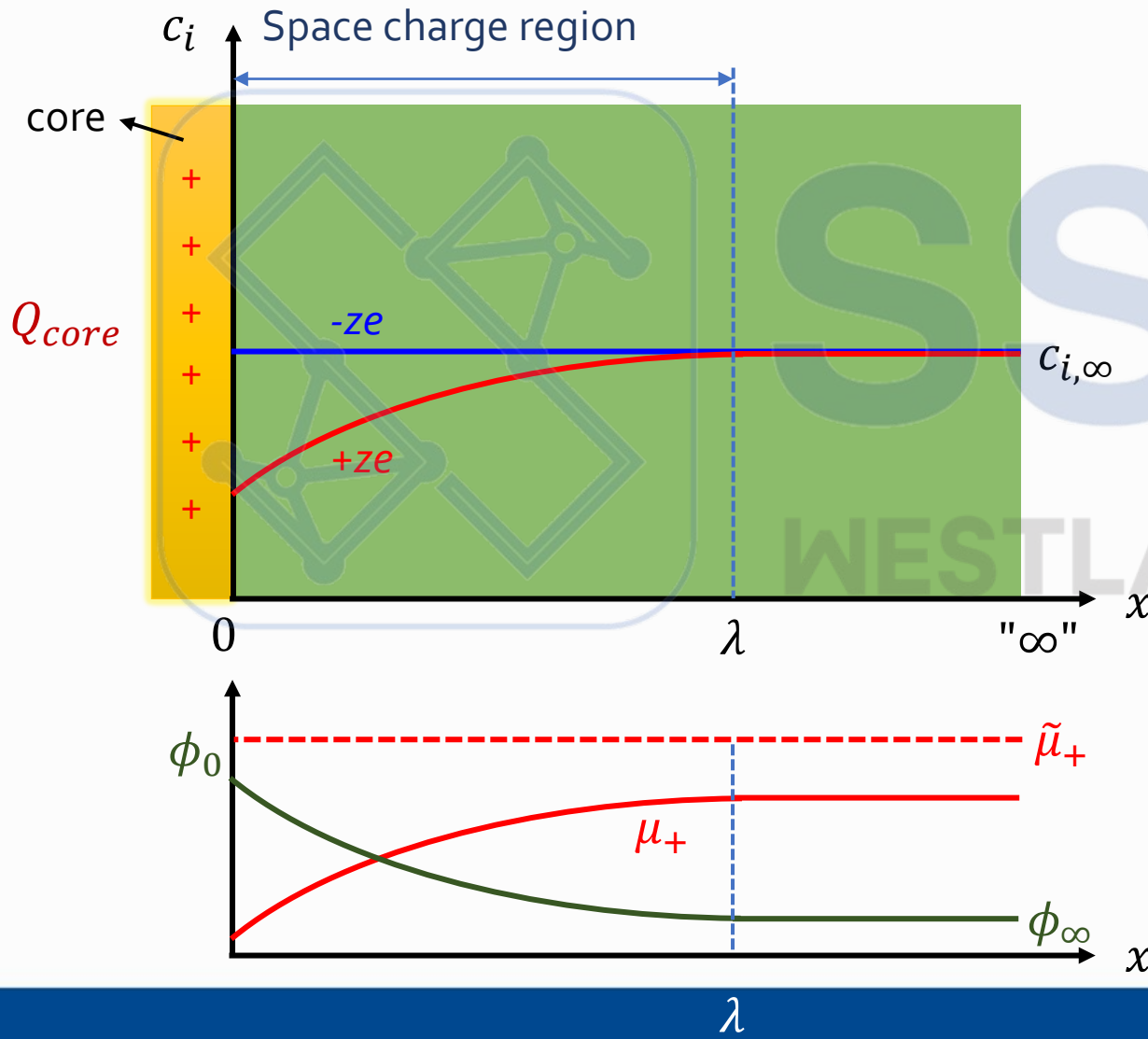
$$\rho(x) \approx -ze c_-(x) = -ze c_{i,\infty}$$

Apply Poisson's eqn.:

$$\frac{d^2 \phi}{dx^2} = - \frac{\rho(x)}{\epsilon_0 \epsilon_r} = \frac{ze c_{i,\infty}}{\epsilon_0 \epsilon_r}$$

\downarrow
const.

Mott-Schottky case: concentration/potential profile



Poisson's eqn.

$$\frac{d^2\phi}{dx^2} = -\frac{\rho(x)}{\epsilon_0\epsilon_r} = \frac{zec_{i,\infty}}{\epsilon_0\epsilon_r}$$

We need to integrate **twice** to get the potential profile.

Boundary conditions are:

$$\phi(0) = \phi_0 \text{ \& \& } \phi(\lambda) = \phi_\infty = 0$$

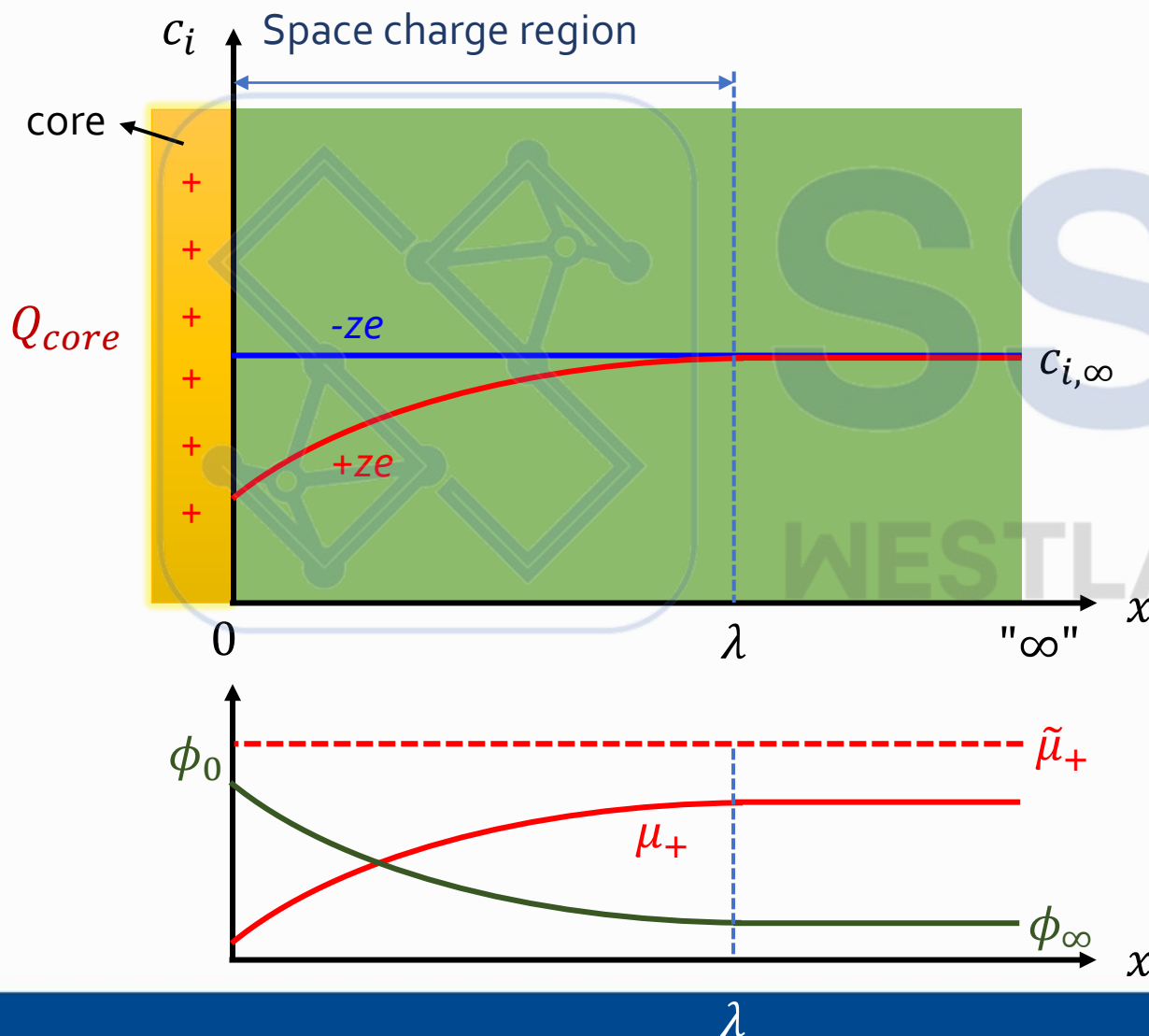
$$\phi'(\lambda) = 0$$

$$\phi'(x) = \frac{zec_{i,\infty}}{\epsilon_0\epsilon_r}(x - \lambda)$$

$$\phi(x) = \frac{zec_{i,\infty}}{2\epsilon_0\epsilon_r}(x - \lambda)^2$$

$$\lambda = \sqrt{\frac{2\epsilon_0\epsilon_r\phi_0}{zec_{i,\infty}}}$$

Mott-Schottky case: how to set up the problem?



$$\phi(x) = \frac{ze c_{i,\infty}}{2\epsilon_0 \epsilon_r} (x - \lambda)^2, \lambda = \sqrt{\frac{2\epsilon_0 \epsilon_r \phi_0}{ze c_{i,\infty}}}$$

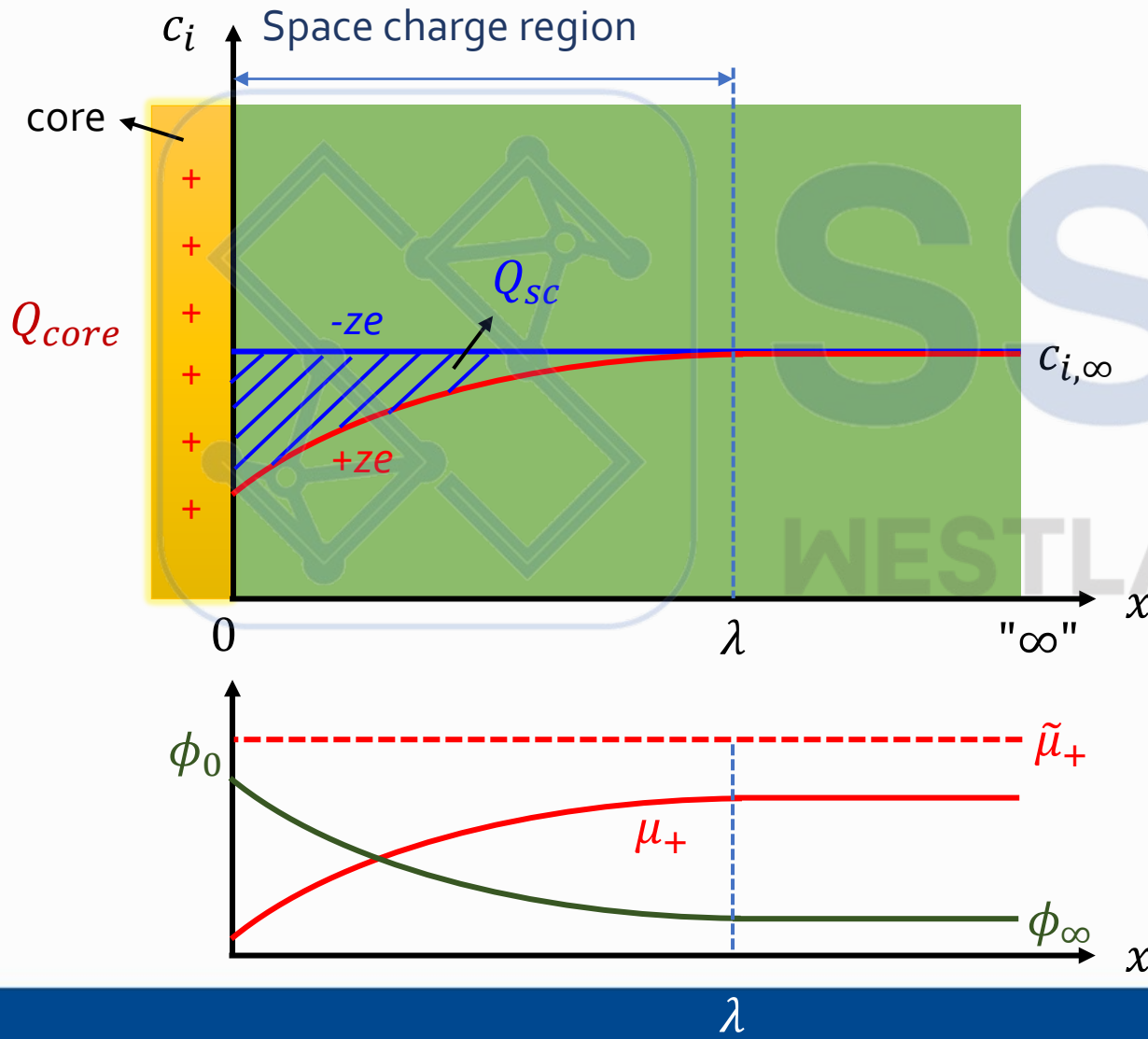
This solution only applies *within* the space charge region.

$$\phi(x) = \begin{cases} \phi_0 \left(\frac{x}{\lambda} - 1\right)^2 & 0 < x \leq \lambda \\ 0 & x > \lambda \end{cases}$$

$$\lambda = \sqrt{\frac{2\epsilon_0 \epsilon_r \phi_0}{ze c_{i,\infty}}}$$

$$\frac{c_+(x)}{c_{i,\infty}} = \exp\left(-\frac{ze \phi_0}{k_B T} \left(\frac{x}{\lambda} - 1\right)^2\right) \quad (0 < x \leq \lambda)$$

Mott-Schottky case: total charges in space charge region



If we think about the whole sample (**core** + **space charge region** + **bulk**), the charge neutrality condition should still apply.

Therefore, we have:

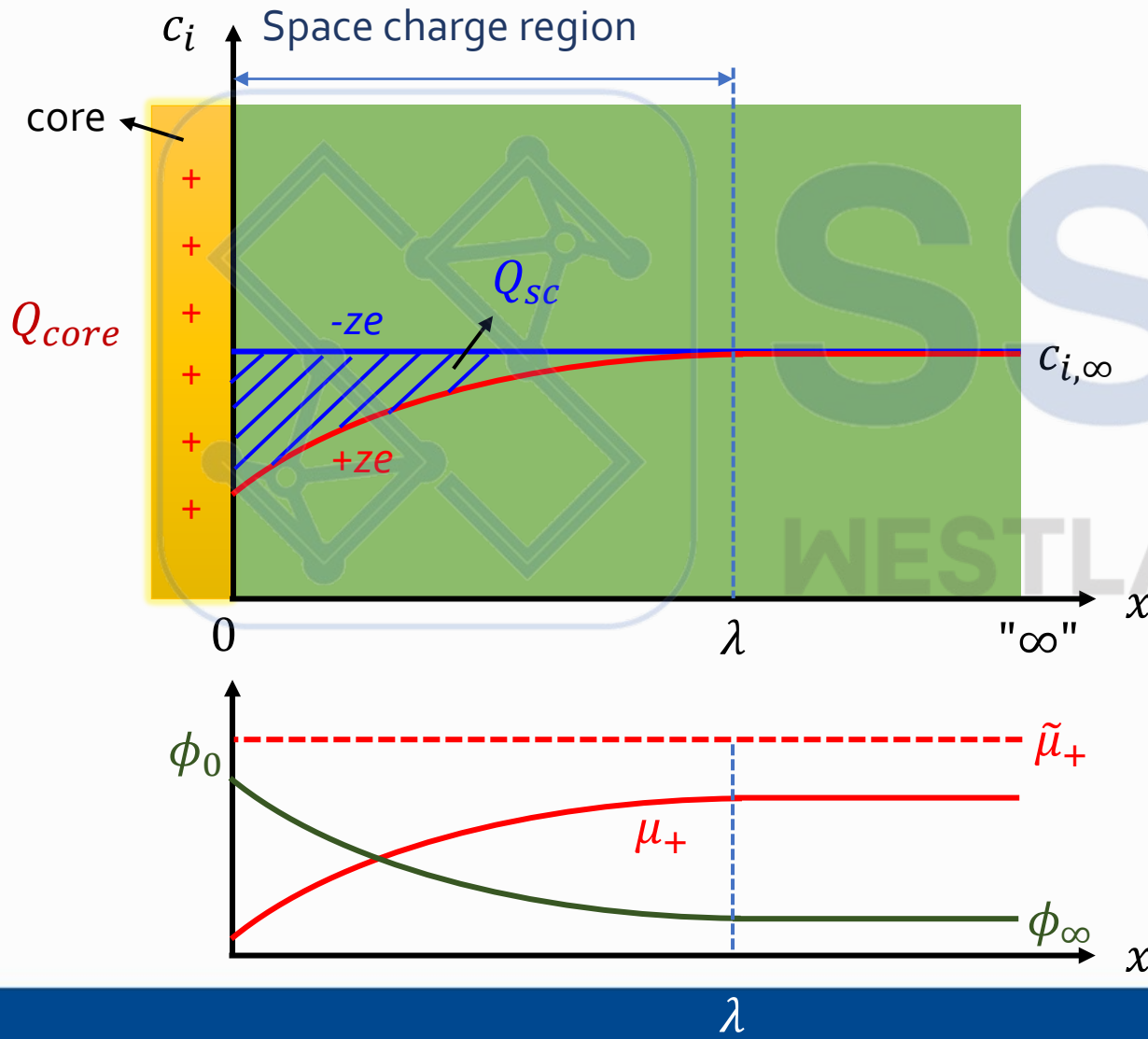
$$Q_{core} = -Q_{sc} \approx zec_{i,\infty}\lambda$$

In other words, if we know the core charge Q_{core} , then we can predict the width of the space charge region λ :

$$\lambda = \frac{Q_{core}}{zec_{i,\infty}}$$

We can further calculate ϕ_0 using: $\lambda = \sqrt{\frac{2\varepsilon_0\varepsilon_r\phi_0}{zec_{i,\infty}}}$

Mott-Schottky case: Gauss's Law



We can reach the same conclusion by applying 1-D Gauss's Law:

Electric field $\leftarrow E = \frac{Q_{enc}}{\epsilon_0 \epsilon_r} \rightarrow$ "enclosed charge"

At position $x = 0$:

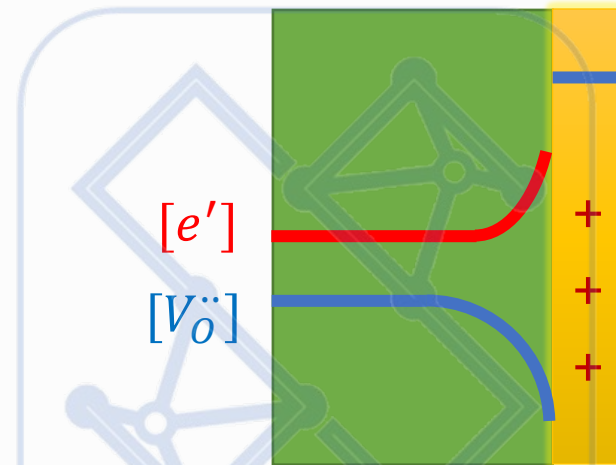
$$\phi(x) = \phi_0 \left(\frac{x}{\lambda} - 1 \right)^2$$

$$E(x) = -\frac{d\phi}{dx} = -\frac{2\phi_0}{\lambda} \left(\frac{x}{\lambda} - 1 \right)$$

$$E(0) = \frac{2\phi_0}{\lambda} = \frac{Q_{core}}{\epsilon_0 \epsilon_r} \quad \lambda = \sqrt{\frac{2\epsilon_0 \epsilon_r \phi_0}{ze c_{i,\infty}}}$$

Compare Gouy-Chapman and Mott Schottky cases

Gouy-Chapman case
(All defects are mobile)

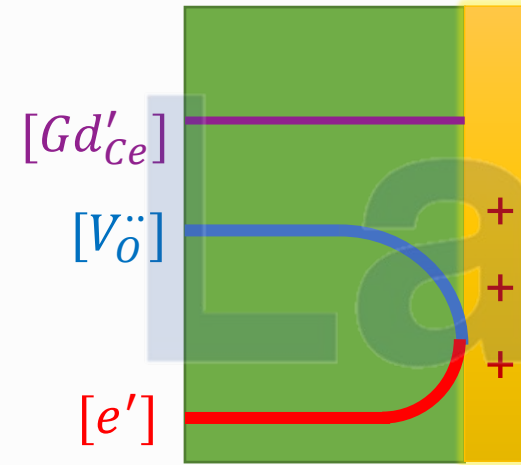


Space charge layer
(SCL) width

$$\lambda_D = \sqrt{\frac{\epsilon_0 \epsilon_r k_B T}{2 z_i^2 c_{i,\infty} e^2}}$$

Independent on the core charge Q_{core}

Mott-Schottky case
(Majority dopants are frozen (*immobile*))



$$\lambda = \sqrt{\frac{2 \epsilon_0 \epsilon_r \phi_0}{z e c_{i,\infty}}}$$

or

$$\lambda = \frac{Q_{core}}{z e c_{i,\infty}}$$

Dependent on the core charge Q_{core}

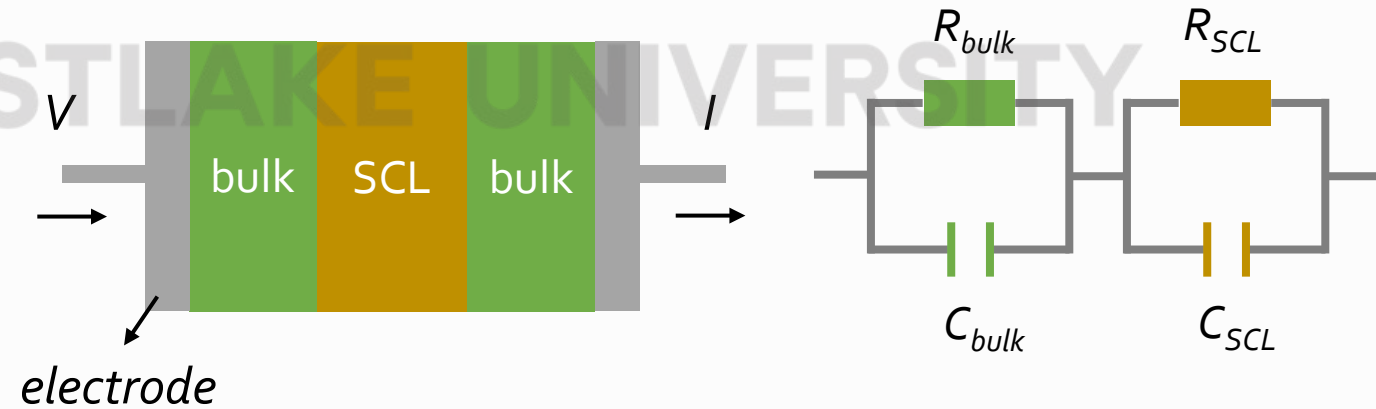
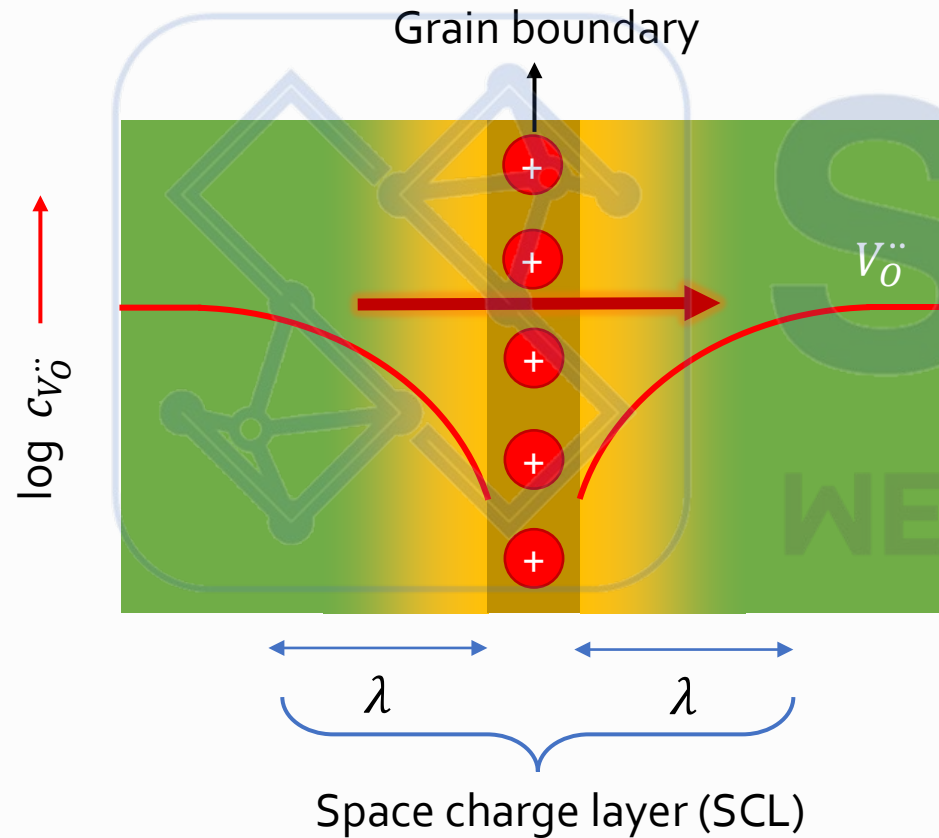
In both cases, a higher bulk concentration $c_{i,\infty} \rightarrow$ shorter SCL width (*faster screening*)

Implications on the conductivity: series layer model

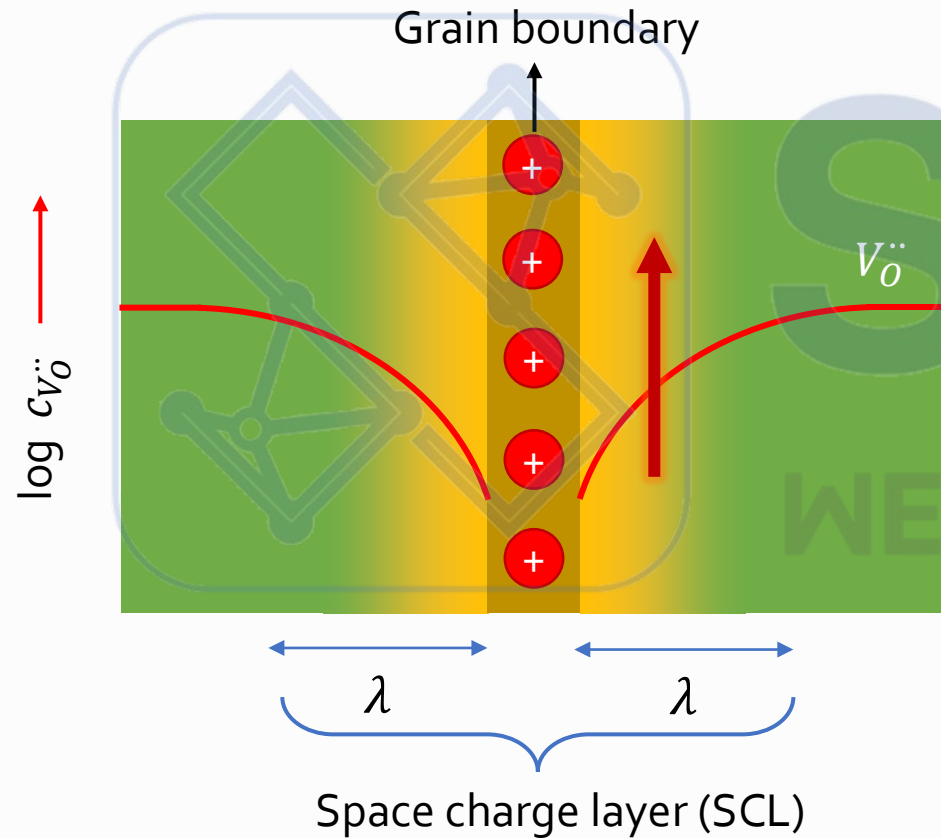
$$\sigma_{ion} = c_{V_O^{\bullet\bullet}} z_{V_O^{\bullet\bullet}} F M_{V_O^{\bullet\bullet}}$$

If we assume the mobility of $V_O^{\bullet\bullet}$ is the same in the bulk and grain boundary, then the ionic conductivity is mainly affected by the depletion of oxygen vacancies.

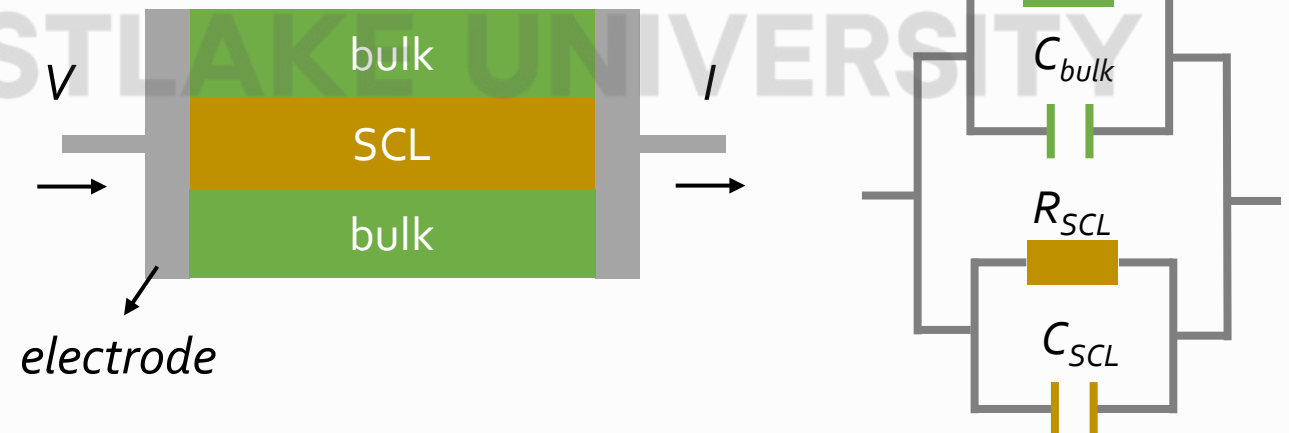
Consider the series layer model:



$$\sigma_{ion} = c_{V_O^{\bullet\bullet}} z_{V_O^{\bullet\bullet}} F M_{V_O^{\bullet\bullet}}$$

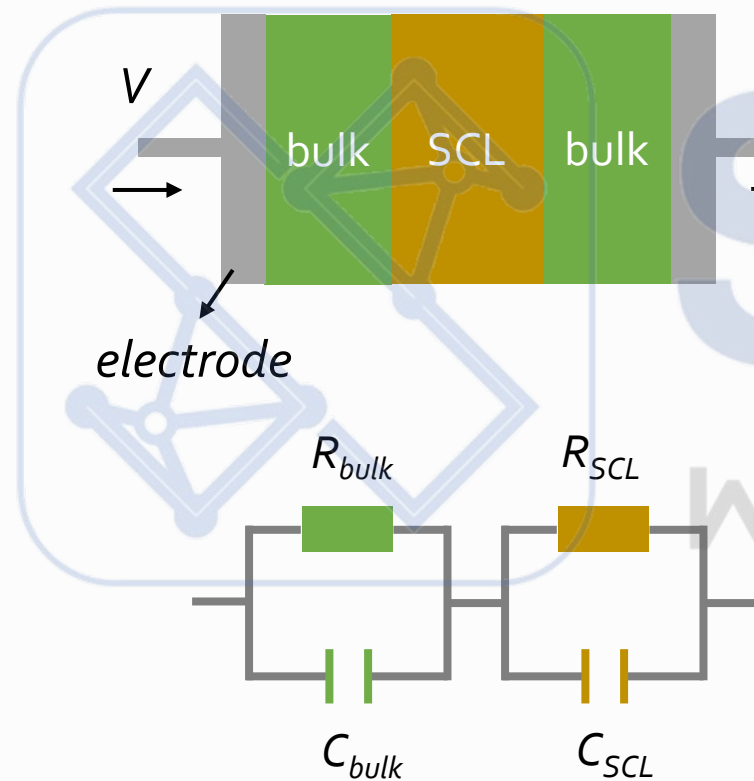


We can also construct the parallel layer model:

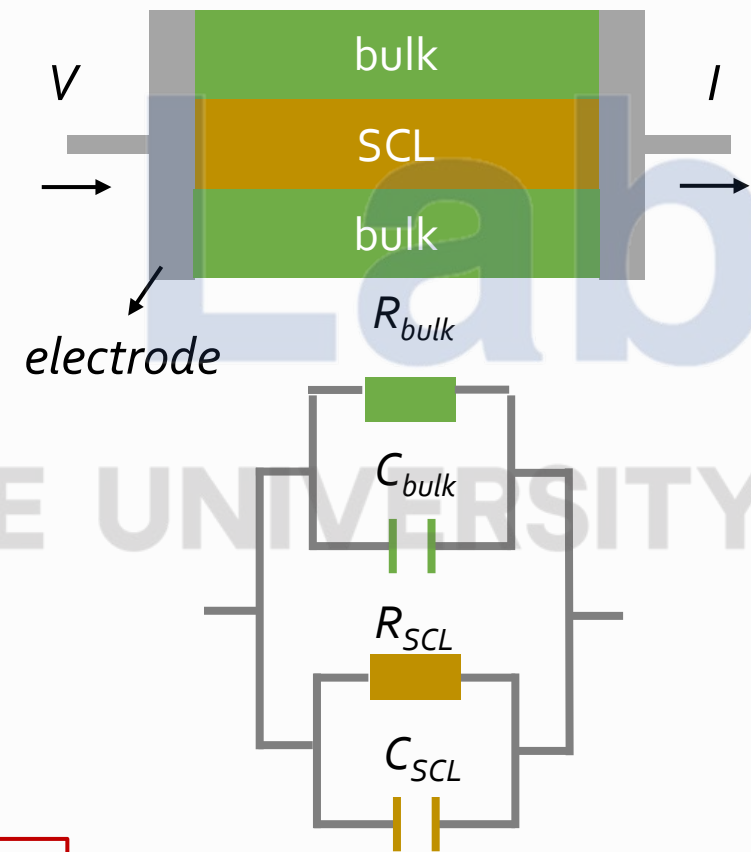


Question: how to evaluate resistance and capacitance?

Series layer model



Parallel layer model



How to theoretically model and experimentally measure R_{SCL} & C_{SCL} ?

Space charge layers:

- What is the physical picture and assumptions of the space charge layer theory?
- How to model the distribution of ionic/electronic defects in the space charge layers?
- What are the difference between the Gouy-Chapman and Mott-Schottky cases?
- How to model the distribution of ionic/electronic defects in the space charge layers?
- What are the effects of space charge layers on the conductivity of bulk (poly-crystalline) materials?

Goal of this lecture: you should be able to answer the questions above by the end of this lecture :)

End of Lecture 7

Solid State Ionics Fall 2023

西湖大學

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